

MOSFET - Power, Single N-Channel, STD Gate, SO8-FL

40 V, 0.52 mΩ, 414 A

NVMFWS0D5N04XM

Features

- Low $R_{DS(on)}$ to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Small Footprint (5 x 6 mm) with Compact Design
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

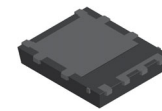
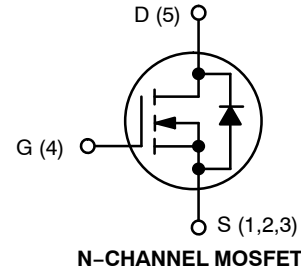
- Motor Drive
- Battery Protection
- Synchronous Rectification

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	40	V
Gate-to-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	$T_C = 25^\circ\text{C}$	414
		$T_C = 100^\circ\text{C}$	293
Power Dissipation	P_D	163	W
Pulsed Drain Current	I_{DM}	$T_C = 25^\circ\text{C}, t_p = 10 \mu\text{s}$	900
Pulsed Source Current (Body Diode)			I_{SM}
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to +175	$^\circ\text{C}$
Source Current (Body Diode)	I_S	251	A
Single Pulse Avalanche Energy	$I_{PK} = 28.2 \text{ A}$	E_{AS}	1434 mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	T_L	260	$^\circ\text{C}$

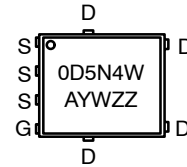
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

$V_{(BR)DSS}$	$R_{DS(on) MAX}$	$I_D MAX$
40 V	0.52 mΩ @ 10 V	414 A



DFNW5 (SO-8FL WF)
CASE 507BD

MARKING DIAGRAM



- A = Assembly Location
- Y = Year
- W = Work Week
- ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

NVMFWS0D5N04XM

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Note 2)	$R_{\theta JC}$	0.92	°C/W
Thermal Resistance, Junction-to-Ambient (Notes 1, 2)	$R_{\theta JA}$	38.9	

- Surface-mounted on FR4 board using 650 mm² pad, 2 oz Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0 V, I_D = 1 mA, T_J = 25^\circ C$	40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS} / \Delta T_J$	$I_D = 1 mA$, Referenced to 25°C		15		mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 40 V, T_J = 25^\circ C$			1	μA
		$V_{DS} = 40 V, T_J = 125^\circ C$			60	
Gate-to-Source Leakage Current	I_{GSS}	$V_{GS} = 20 V, V_{DS} = 0 V$			100	nA

ON CHARACTERISTICS

Drain-to-Source On Resistance	$R_{DS(on)}$	$V_{GS} = 10 V, I_D = 50 A, T_J = 25^\circ C$		0.43	0.52	mΩ
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 240 \mu A, T_J = 25^\circ C$	2.5	3.0	3.5	V
Gate Threshold Voltage Temperature Coefficient	$\Delta V_{GS(TH)} / \Delta T_J$	$V_{GS} = V_{DS}, I_D = 240 \mu A$		-7.21		mV/°C
Forward Trans-conductance	g_{FS}	$V_{DS} = 5 V, I_D = 50 A$		267		S

CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C_{ISS}	$V_{DS} = 25 V, V_{GS} = 0 V, f = 1 MHz$		6232		pF	
Output Capacitance	C_{OSS}			3987			
Reverse Transfer Capacitance	C_{RSS}			53.9			
Total Gate Charge	$Q_G(TOT)$	$V_{DD} = 32 V, I_D = 50 A, V_{GS} = 6 V$		60.5		nC	
Total Gate Charge	$Q_G(TOT)$		$V_{DD} = 32 V, I_D = 50 A, V_{GS} = 10 V$		97.9		
Threshold Gate Charge	$Q_G(TH)$				18.2		
Gate-to-Source Charge	Q_{GS}				27.4		
Gate-to-Drain Charge	Q_{GD}				18.5		
Gate Resistance	R_G			$f = 1 MHz$			0.47

SWITCHING CHARACTERISTICS

Turn-On Delay Time	$t_{d(ON)}$	Resistive Load, $V_{GS} = 0/10 V, V_{DD} = 32 V, I_D = 50 A, R_G = 0 \Omega$		8.64		ns
Rise Time	t_r			7.02		
Turn-Off Delay Time	$t_{d(OFF)}$			13.7		
Fall Time	t_f			6.85		

SOURCE-TO-DRAIN DIODE CHARACTERISTICS

Forward Diode Voltage	V_{SD}	$I_S = 50 A, V_{GS} = 0 V, T_J = 25^\circ C$		0.8	1.2	V
		$I_S = 50 A, V_{GS} = 0 V, T_J = 125^\circ C$		0.65		
Reverse Recovery Time	t_{RR}	$V_{GS} = 0 V, I_S = 50 A, di/dt = 100 A/\mu s, V_{DD} = 32 V$		101		ns
Charge Time	t_a			56.9		
Discharge Time	t_b			44.8		
Reverse Recovery Charge	Q_{RR}			286		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

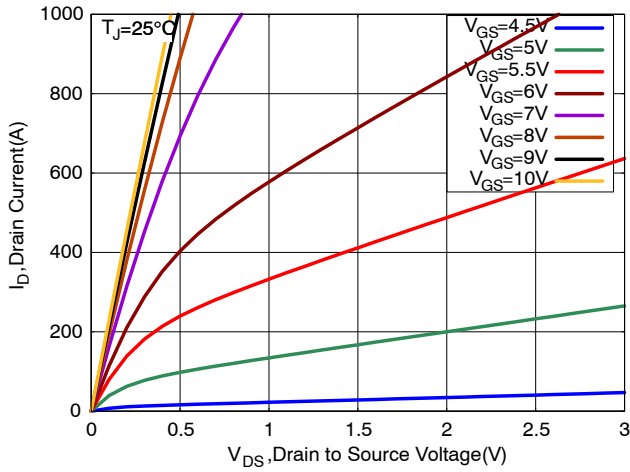


Figure 1. On-Region Characteristics

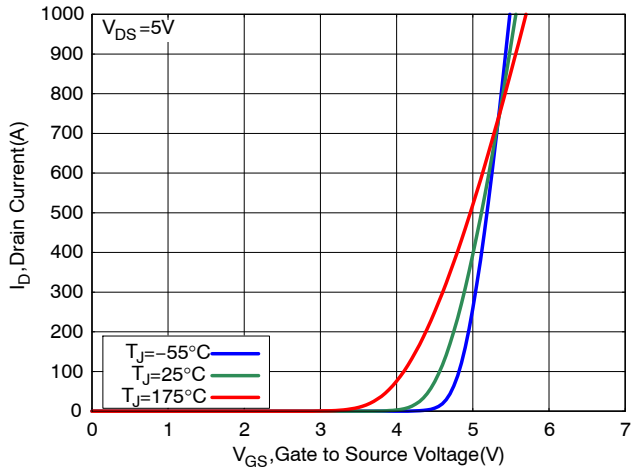


Figure 2. Transfer Characteristics

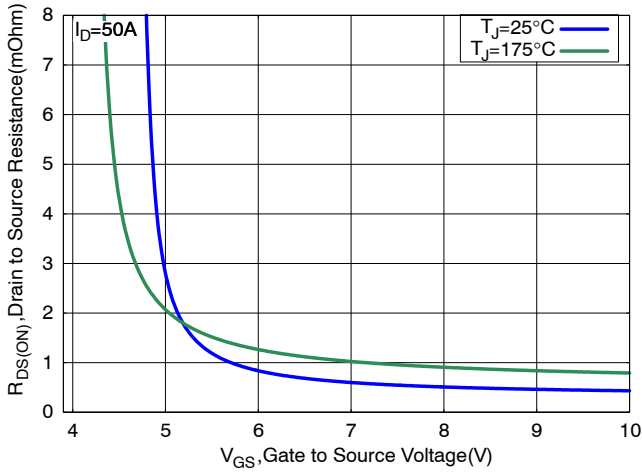


Figure 3. On-Resistance vs. Gate Voltage

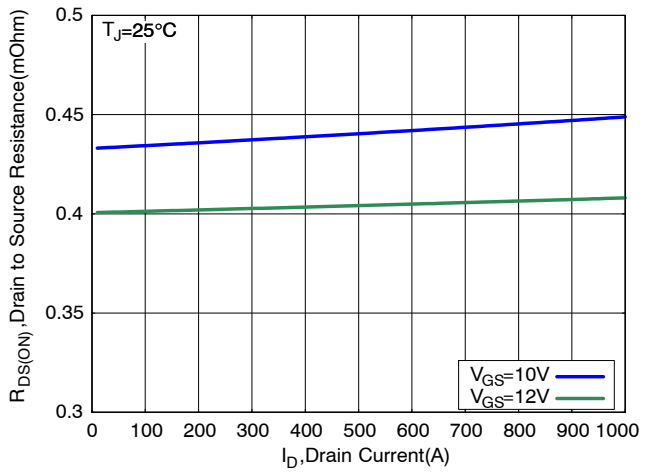


Figure 4. On-Resistance vs. Drain Current

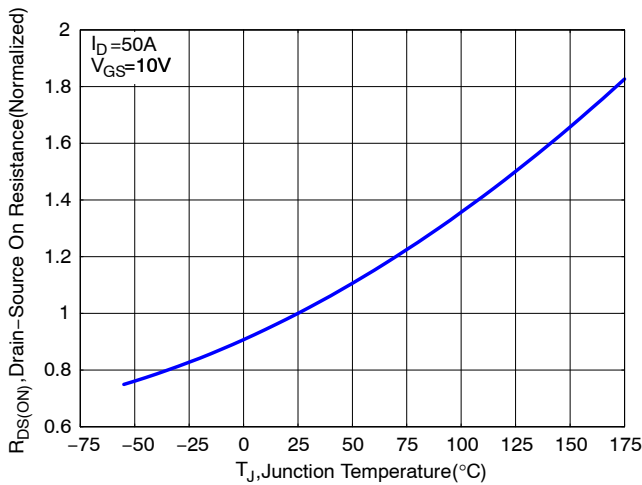


Figure 5. Normalized ON Resistance vs. Junction Temperature

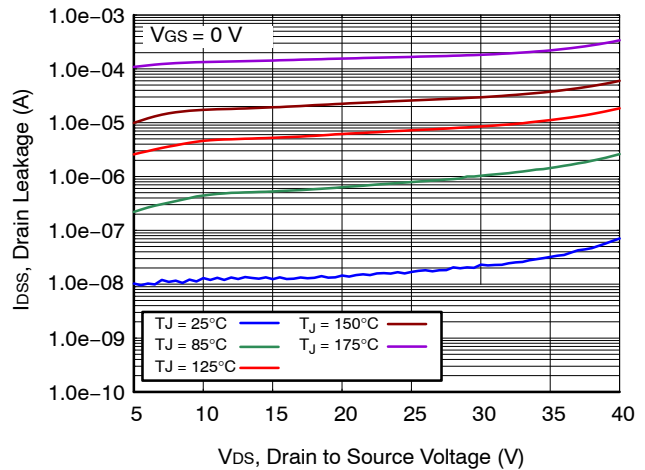


Figure 6. Drain Leakage vs. Drain to Source Voltage

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TYPICAL CHARACTERISTICS (continued)

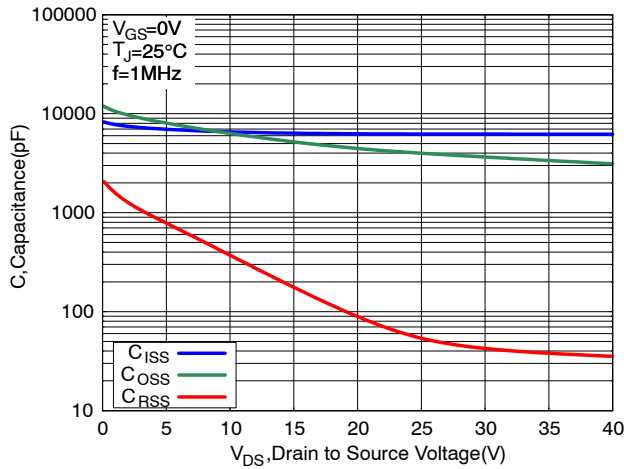


Figure 7. Capacitance Characteristics

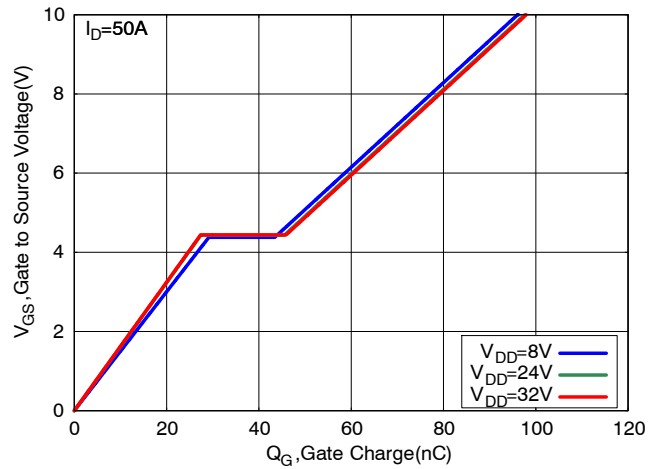


Figure 8. Gate Charge Characteristics

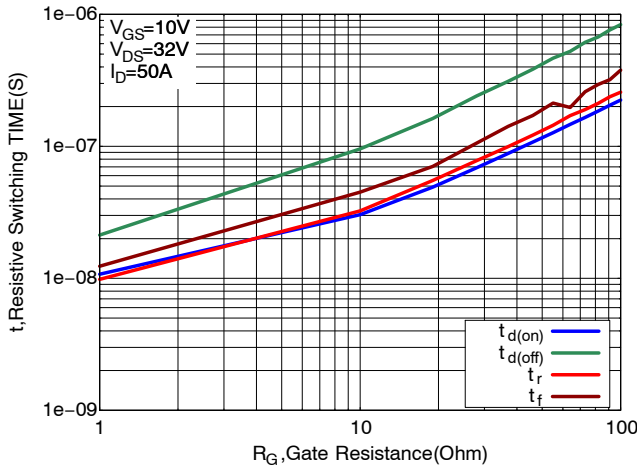


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

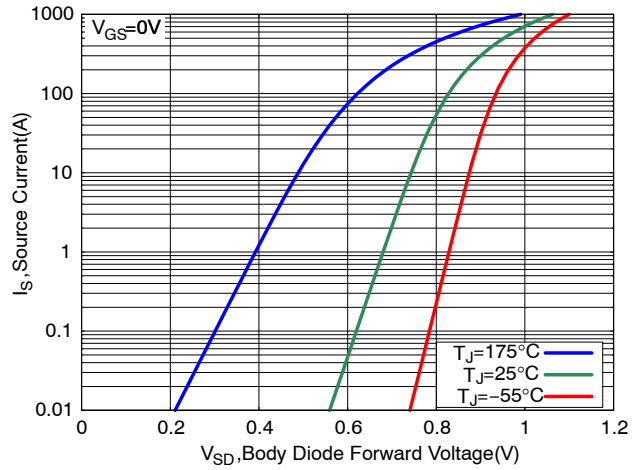


Figure 10. Diode Forward Characteristics

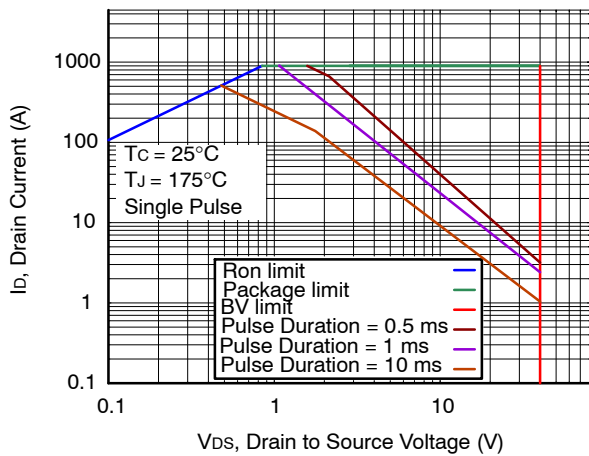


Figure 11. Maximum Rated Forward Biased Safe Operating Area

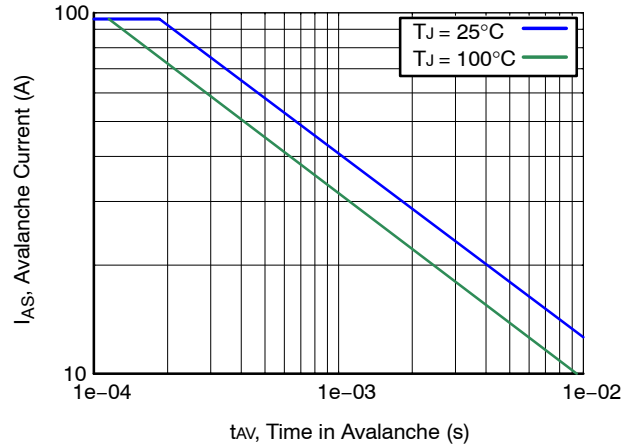


Figure 12. I_{peak} vs. Time in Avalanche

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TYPICAL CHARACTERISTICS (continued)

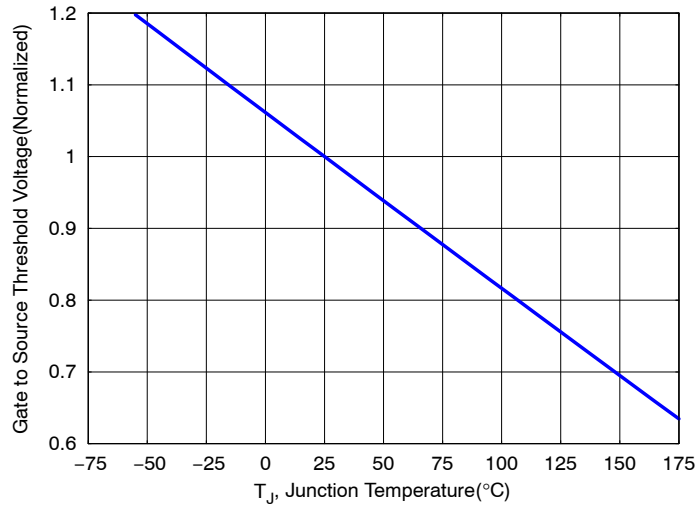


Figure 13. Gate Threshold Voltage vs. Junction Temperature

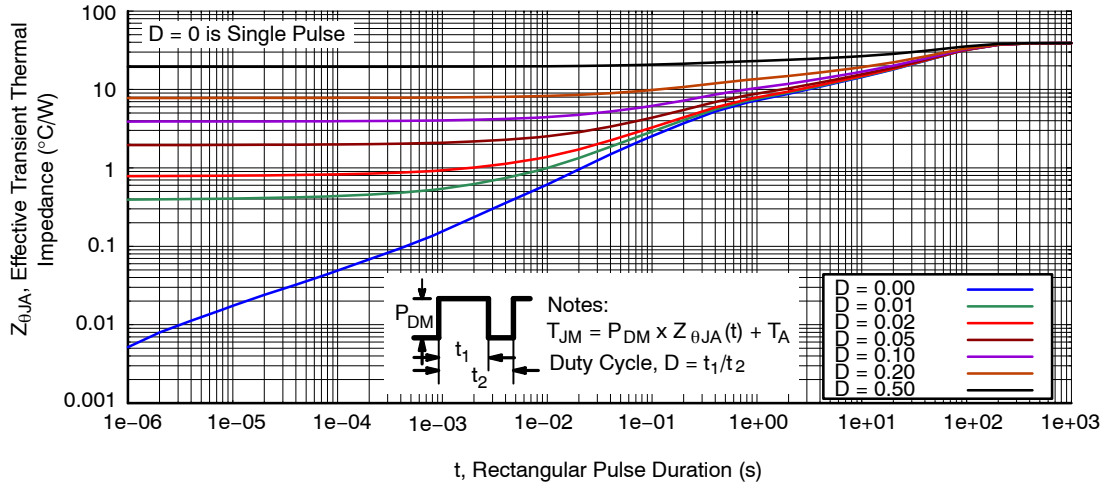


Figure 14. Thermal Characteristics

DEVICE ORDERING INFORMATION

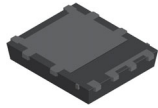
Device	Marking	Package	Shipping [†]
NVMFWS0D5N04XMT1G	0D5N4W	DFNW5 (Pb-Free)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MECHANICAL CASE OUTLINE

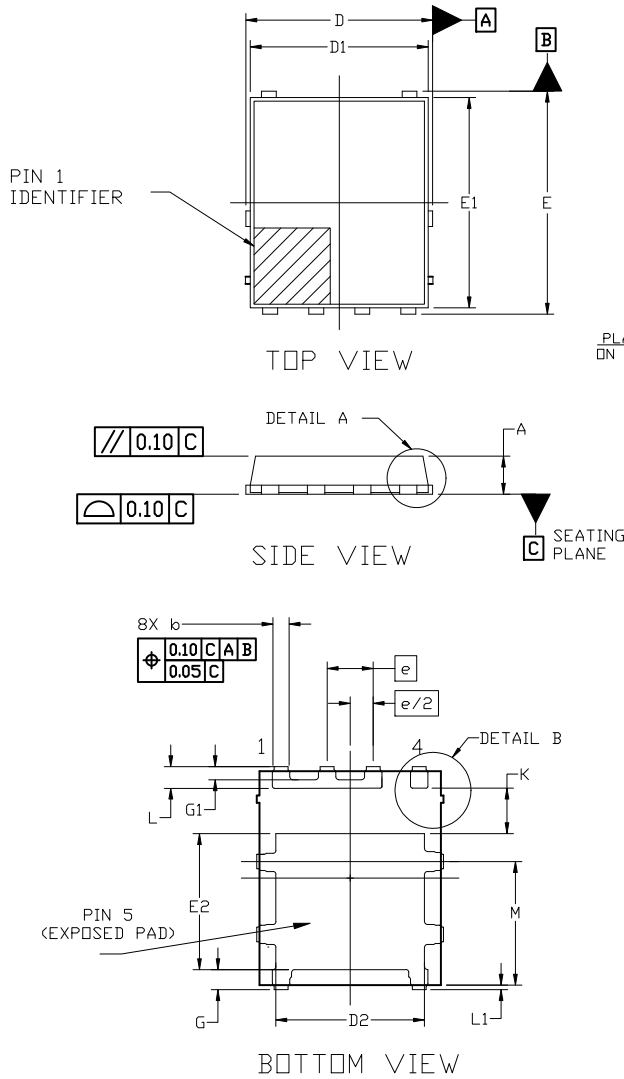
PACKAGE DIMENSIONS

ON Semiconductor®



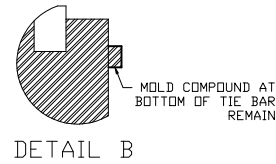
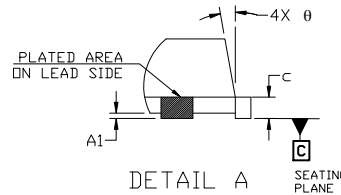
DFNW5 5x6, FULL-CUT SO8FL WF CASE 507BD ISSUE O

DATE 13 APR 2021

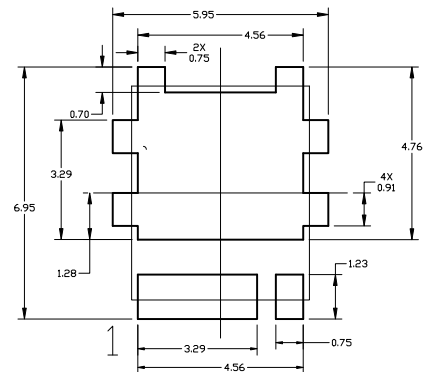


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
4. THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.



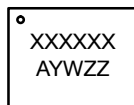
DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
A1	0.00	---	0.05
b	0.33	0.41	0.51
c	0.23	0.28	0.33
D	5.00	5.15	5.30
D1	4.80	5.00	5.20
D2	3.90	4.10	4.30
E	6.00	6.15	6.30
E1	5.70	5.90	6.10
E2	3.55	3.75	3.95
e	1.27 BSC		
G	0.50	0.55	0.70
G1	0.26	0.36	0.46
k	1.10	1.25	1.40
L	0.50	0.60	0.70
L1	0.150 REF		
M	3.00	3.40	3.80
θ	0°	---	12°



RECOMMENDED MOUNTING FOOTPRINT

* For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERM/D.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
Y = Year
W = Work Week
ZZ = Assembly Lot

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	DFNW5 5x6, FULL-CUT SO8FL WF	PAGE 1 OF 1

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